Magnetic properties of Ising thin-lms with cubic lattices

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Abstract

We have used Monte Carlo simulations to observe the magnetic behaviour of Ising thin- Imswith cubic lattice structures as a function of temperature and thickness especially in the critical region. The fourth order Binder cumulant is used to extract critical temperatures, and an extension of nite size scaling theory for reduced geometry is derived to calculate the critical exponents. Magnetisation and magnetic susceptibility per spin in each layer are also investigated. In addition, mean-eld calculations are also performed for comparison. We not that the magnetic behaviour changes from two dimensional to three dimensional character with increasing thickness of the Im. The crossover of the critical temperature from a two dimensional to a bulk value is also observed with both the Monte Carlo simulations and the mean-eld analysis. Nevertheless, the simulations have shown that the critical exponents only vary a little from their two dimensional values. In particular, the results for Imswith up to eight layers provide a strong indication of two dimensional universality.

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I. INTRODUCTION

Studies of the dimensional crossover of magnetic properties from two dimensional (2d) to three dimensional (3d) character in magnetic multi-layers have currently attracted much interest. An understanding of the physical properties of solids as the dimensionality is reduced is of both technological and fundamental importance [1, 2]. In particular, studies of ultrathin magnetic lms have revealed a number of novel phenomena that would not have been expected in either 2d or 3d systems. Of particular interest is the critical behaviour of magnetic thin—lms, for which the dimensionality d is not well established. It is interesting to consider how magnetic properties such as the magnetisation m, magnetic susceptibility—and critical temperature $T_{\rm C}$ are a ected by the niteness of the system in the direction perpendicular to the—lm.

From both theoretical and experim ental studies, the critical tem perature $T_{\rm C}$ is found to increase with Im thickness. Nevertheless, how the thickness lofthe Im relates to the dimensional crossover of other magnetic critical properties from 2d to bulk 3d is not fully understood. Most studies imply that magnetic Ims belong to a 2d universality class regardless of the thickness. This is commonly understood to be a consequence of the niteness of the Ims along the out-of-plane direction. Close to the phase transition point (critical temperature $T_{\rm C}$) the correlation length is constrained by thickness and allowed to expand only in the in-plane direction. This is certainly a 2d-like phenomenon. However, well-known experimental studies of thin—Ims of nickel [3] have shown contrary evidence where a dimensional crossover of the critical exponent from 2d to 3d has been found. Hence, to clarify this discrepancy, we consider the use of Ising thin—Ims to study such a phenomenon in cubic lattices, that is simple cubic (sc), body centred cubic (bcc) and face centred cubic (fcc).

The Ising model represents a ferrom agnet with in nite uniaxial anisotropy. It is useful because strong magnetic anisotropies are common in ultrathin ferrom agnetic. In s and monolayers. In addition, it turns out that 2d anisotropic Heisenberg systems become Ising-like near $T_{\rm C}$. This was shown by Binder and Hohenberg [4] using Monte Carlo simulations and has been proven rigorously by Bander and Mills [5] using renormalisation group analysis. Also, from the experimental point of view, experiments on nickel [3] and iron thin-lms [6] have shown 2d results in agreement with Ising 2d critical exponents. These all suggest that the Ising model is a handy tool to study magnetic thin-lms.

Previous studies of Ising thin- Ims have been by means of the high temperature expansion [7, 8], renorm alisation group [9], variational cum ulant expansion (VCE) [10] and M onte Carlo [11, 12] m ethods. However, most of them have concentrated on the study of the critical temperature and shift exponent in the sc lattice. Few have investigated the e ective critical exponents in order to determ ine how they vary as a function of temperature away from T_C . As far as we are aware, nothing exists in the literature reporting the investigation of critical exponents as a function of thickness at the critical point. This is mainly due to a presum ption that the Ims are of the 2d class as well as diculties in the analysis due to nite size e ects. Hence, in this study, we aim to give a more complete picture of the magnetic phase transition in thin-lms especially at the critical point. We have investigated how the magnetic properties vary as a function of tem perature and thickness by means of Monte Carlo simulations and mean-eld theory. We have also calculated the critical temperature and investigated its convergence to the bulk limit. Most crucially, we have developed an extension to nite size scaling analysis to observe how the critical exponents vary as a function of thickness. In outline, we stly describe the numerical calculations and the methods we have used. Secondly, we show the evolution of the magnetic properties as a function of temperature and thickness. Then, we report the critical properties of thin- Im s in term s of critical tem peratures and exponents. Finally, we discuss our results and compare the characteristic critical exponents with those found in experim ents.

II. METHODOLOGY

The starting point for the study is the nearest neighbor Ising ham iltonian

$$H = J X S_{i}S_{j}; \qquad (1)$$

where the spin S_i takes on the values $\ 1$ and the sum includes only $\ rst$ nearest-neighbor (1nn) pairs. Helicaland free boundary conditions are used in our simulations using this ham iltonian for the in-plane and out-of-plane directions respectively. We use units of $J=k_B$ and J for temperature and energies respectively with the magnetisation per spin de ned as $m=\frac{1}{N}$ S_i where N is total number of spins.

The simulations are carried out for sc, fcc and bcc lms of size N = L l lwhere L L represents the number of sites in each layer of the lm and l is the number of layers in the lm i.e. its thickness. We vary L from 64 to 128 (in steps of 8) with l ranging from a monolayer (bilayer for bcc lms) to 20 layers. The spin con gurations of the lms are updated using the highly e cient W ol algorithm [13] to minimise the elect from statistical errors arising from correlation time [14, 15]. The random number generator (drand48) is chosen carefully [16, 17, 18] and we ensure that dierent seed numbers have no significant elect on the results. For each simulation, roughly 3;000 N spins are updated before the system is deemed to have reached equilibrium. From this point, 5 10 independent con gurations are used to calculate the expectation of magnetisation per spin $0 < m > 10 < m^2 > 0 <$

 $J=k_B T$). In a similar fashion, the layer-dependence of these magnetic properties, m $_k$ and $_k$, where k is a layer index, are calculated in order to observe the surface elects upon the magnetic properties. For the investigation of the critical behaviour of the lms, we locate the critical temperatures (T_E) via the fourth order cumulant T_{L} [19]

$$U_{L} = 1 \quad \frac{1}{3} < m^{4} > 2$$
 (2)

At $T=T_C$, U_L should be independent of L, i.e. for diering sizes L, L^0 ($U_L \circ = U_L$) $_{T=T_C}=1.0$ wing to nite size elects, we need to plot T_C (b) ($L=bL^0$) against ($\ln b$) 1 , and extrapolate the results to the ininit i.e. ($\ln b$) 1 ! 0 [19]. To maxim ise the eleciency of this T_C calculation, for each thickness, we perform a single long simulation at a temperature T_0 and use the histogram method [20, 21] to extrapolate U_L to a temperature nearby in order to and the cumulant crossing point. This temperature is chosen from the temperature at the peak of the magnetic susceptibility curve for the L=128 system, and then around 1 to 4 million spin conquirations are used to create the histograms. To exclude those data obtained from temperatures too far from the simulated temperature T_0 , the range of extrapolation T_0 is restricted by the criterion T_0 (T) T_0 is a standard deviation of T at T_0 .

The next step is to extract the critical exponents from our nite size results. To do this we have developed a nite size scaling method appropriate for lm s in which l=L 1. The purpose is to nd how magnetic properties m and scale with the size L and lofthe systems. The basic nite size scaling ansatz (e.g. [23, 24, 25, 26, 27, 28]) rests on an assumption that only a single correlation length is needed to describe the critical properties of thin—lm s. As detailed in Appendix A this gives the following general form for how the magnetisation and susceptibility scale with L

$$< m (T;1)> = L = m (L^{1=} t;1);$$

 $(T;1) = L^{(=)^0} e (L^{1=} t;1);$ (3)

where (= $)^0$ = = +2 d. , and are the critical exponents associated with ,m and respectively, e and m are scaling functions for a given l and t = 1 $\frac{T}{T_C}$ is the reduced temperature. These scaling functions for a range of L should collapse onto a single curve with the correct critical temperature and exponents. The exponent 1= can be extracted from the derivative of the cumulant with respect to L at T_C

ow ing to its variation with system size as $L^{1=}$ [19]. Since we have assumed that there is a single / t a single is to be expected. Note that if equations (3) correctly encapsulate the nature of magnetic critical behaviour in lms, we can extract the exponents = and (= 0)by plotting logm and log against log L at $T_{\rm C}$. Before this can be done with condence it is necessary to demonstrate the validity of the assumption of a single correlation length and thus the form of equations (3). This can be done by establishing the following:

- 1. A coording to eqn. (3), at T_c , if we plot \log (m) against $\log L$ we should get a straight line.
- 2. We should not that the sum of $(=^{\circ})+2(=)$ is always equal to 2. This again can be derived using the assumption of a single correlation length and =+2== d [29] i.e.

3. The clearest demonstration comes from a direct examination of the scaling functions them selves, eqn. (3). With correct exponents in the critical region, a scaling function for any L but a particular 1 should collapse onto a single curve. This will also con me the reliability of the critical exponents extracted from our simulations

III. RESULTS AND DISCUSSION

A. M agnetisation and M agnetic Susceptibility

The magnetisation m and susceptibility pro less for various lm thicknesses l and system sizes L are obtained. The crossover of magnetic behaviour from 2d-like for the monolayer (bilayer in bcc) to 3d-like for lm s with 20 or more layers is found. For example, Fig. 1a,b shows the magnetic phase transition for a system of 128 128 1 spins. The transition point moves from 2d to 3d values with increasing lm thickness. The layer resolution of these magnetic properties is also investigated. The in uence of the surface on the magnetic properties can also be seen. For instance, Fig. 1c and d show the layer-dependence of m $_{\rm k}$ and $_{\rm k}$ for the 128 128 10 system. The surface layer has the lowest magnetisation magnitude, whilst the magnetisation per site increases towards the interior of the lms. Similarly, for , representing the uctuation of m, the strongest magnitude is for the innermost layer and the weakest is at the surface. The $\rm k^{th}$ and (l $\rm k^{th}$ layers have the same magnetic properties owing to the spatial symmetry and the isotropy of J.

The layer variation of the magnetic properties can be explained in terms of niteness of the thin-lms along the z direction together with the M onte Carlo updating algorithm. In a simulation run, once a seed spin is chosen in order to select a group of spins to be updated with the W ol algorithm, it will have a greater chance of aligning those neighboring spins which are located towards the interior of the lms rather than those towards the surface. Consider the probability for a site getting updated:

D
$$(i; j; k) = \frac{1}{M} \sum_{n=1}^{M} s^{0}(i; j; k);$$
 (5)

where $s^0(i;j;k)$ is the number of times the site at location (i;j;k) is in a Wol update, and M is the total number of clusters forming (ipping) in a simulation. Our simulations show that, in the ferrom agnetic phase, D at the surface layers always has the lowest magnitude, except, at very low T where the chance of a site getting updated is very high and the same anywhere. Thus, this implies that once a cluster of spins is formed, the group has its spins preferentially located in the inner layers rather than near the surface layers. When the group is ipped, the inner layer will always have the high magnetisation magnitude, but at the surface layers, there will be more unped spins behaving as a buer which results in smaller

m agnetisation m agnitude. Sim ilarly, for the susceptibility, the buer in the surface layers helps to reduce the magnetic actuation leading to a smaller susceptibility than for the inner layers.

We not the same qualitative trends by using a mean-eld approximation (see appendix B). The evolution of the magnetic properties from 2d-to 3d-like is again found e.g. for sc lms in Fig. 2a,b. The layer-dependence of magnetic properties is also evident. As expected, the magnetisation per site is smallest on the surface layer and highest on the innermost as can be seen, for example, in Fig. 2c,d which show results for a 10-layered Ising sc lm.

B. Critical Temperatures and Shift Exponents

$$T_{C}(1) = T_{C}(1) \frac{z_{0} + 2z_{1} \cos(-(1+1))}{z_{0} + 2z_{1}};$$
 (6)

where z_0 and z_1 are number of nearest neighbors in the same plane and its adjacent plane respectively. We note our mean-eld results to comply with this expression. A summary of results for $\mathbb F$ from both M onte Carlo and mean-eld calculations is presented in Table I and Fig. 3.

It is revealing to exam ine the evolution of the thin- lm s' critical tem peratures from the monolayer to bulk 3d lim it in term s of a power law

$$1 \quad \frac{T_{C} (1)}{T_{C} (1)} / 1 ; \tag{7}$$

Here T_C (1) is the bulk critical temperature and the shift exponent—has a value between 1.0 and 2.0 depending on the spin model used and the type of calculation. For thick—lms is expected to be $1=^{3d}$ [27]. A better—t for—lms of a range of thicknesses lis given by [32] and has the form

$$\frac{1}{T_{C} (1)} = \frac{1}{T_{C} (1)} {}^{4}1 + \frac{1}{1} {}^{9} {}^{5};$$
 (8)

where l_0 , l^0 and l^0 are all adjustable parameters. Similarly, l^0 should tend to $l=l^{3d}$ as l! 1.

We use eqn. (8) to the T_c (1)'s arising from our M onte Carlo calculations. If it turns out that our T_c (1)'s are accurate and that the t is a useful one, we should not T_c (1) in agreement with the $T_c^{\rm bulk}$ we calculate separately. Results of the t are shown in Table II, and there is less than a 1 percentage di erence between T_c (1) and $T_c^{\rm bulk}$ for all three types of T_c in the Table II, however, even for T_c 1 is not close to the expected large l value, T_c 1 and T_c 20. To elucidate further the evolution from 2d-to 3d-like behaviour we rearrange the power law of eqn. (7) and define

$$e^{(l_{i})} = \log \frac{T_{C}(1)}{T_{C}(1)} \frac{T_{C}(l_{i})}{T_{C}(1)} = \log (\frac{l_{i}}{l_{i}});$$
(9)

and tabulate $_{\rm e}$ ($l_{\rm i}$) with $l_{\rm i}$ for both our M onte Carlo simulations ($l_{\rm i}$ 2 f4;6;8;10;15;20g) and m ean—eld calculations ($l_{\rm i}$ ranging from 4 to 20 layers) in Table II. The $_{\rm e}$'s should converge to asymptotic shift

exponents $1=\ ^{3d}$ when l tends to in nity. A linear least squares—t between $_{\rm e}$ (li) and $1={\rm li}$ enables us to obtain $_{\rm e}$ (l) which is also given in the Table. (The mean—eld values of $_{\rm e}$ (l) for all structures all have values of 2 since the mean—eld—is well-known to be 1=2.) For the M onte C arlo simulations' results, it is gratifying to—nd $_{\rm e}$ (l) to be close to $1=\ ^{3d}$ which we obtain from our separate bulk M onte C arlo simulations. This gives good support to the contention of universality and the asymptotic behaviour contained in eqn. (7,8).

C. Critical Exponents

Referring to equations (3), we notice that the critical exponents can be extracted from plots of logm and log , as well as log $\frac{dU_L}{d}$, against log L at T_C , provided that linear relations are found. This is actually the rst test of the validity of our single correlation length, , assum ption. Results from our simulations, at T_{C} , indeed show very good linear relationships between logm , log $\bar{}$ and log $\frac{dU_{\text{L}}}{d}$ with log L for all our thin- $\operatorname{Im} s'$ thicknesses and structures. We note here that $\frac{dU_L}{d}$ / $L^{1=}$. An example is shown in Fig. 4 which presents very good linear ts for 10-layered sc $\ln s$. Now, the exponents = , ($=^0$,) and 1= can be extracted from the slopes of the linear least square ts. They are listed in Table I. For the second test, we perform the sum mation of the computed exponents - $^{\circ}+2-.$ We have found that, in each case, this sum has a value of 2 within error bars as shown in Fig. 5. A coording to eqn. (4), this passes the second test for the assumption of a single being su cient to describe the critical behaviour of the thin-lms. For the last test, we consider the scaling functions in eqn. (3). We calculate these scaling functions for the 10-layered sc lm s w ith L = 10;20;40;60;80;100;150 and 200 using the exponents extracted from L = 64 to 128. The results are shown in Fig 6a,b. For large enough L (L = 60 to 200), excellent data collapses occur. This con imis that our critical exponents are perfectly reliable. However, in the same gures, for small L (around L = 10 and 20), data collapsing is not found. This is what we must expect since eqn. (3) originated from eqn. (A 6,A 7) (in appendix A) under the condition 1 scaling functions should not be observed if L approaches 1. For comparison, we also present the scaling functions for these 10-layered sc Im susing the 2d m on olayer critical exponents in Fig 6c,d. We can see that the data collapses are not quite as good. This also con m s the reliability of our results.

Since our results pass all of the three tests above, it can be understood that the single is valid and eqn. (3) is very useful for extracting critical exponents from Im systems at To. However, it is unfortunate that we cannot extract the = out of (= $^{\circ})$ from our results. This means that we cannot investigate the dimension das a function of thickness. Nevertheless, we and that the exponents (= 9) and =, for l = 1 up to l = 20 lm s, are quite close to their 2d values as shown in Table I and Fig. 5. In particular, for thin- lm s (1 8), the exponent values seem to be almost identical with the 2d results. On the other hand, for thicker lms (1 10), a weak dependence of the exponents on 1 is found. This is som ew hat reasonable since, in the critical region, although the correlation length is 2d-like in the sense that it can expand freely only in the xy plane, it is still a function of thickness. Suppose that at a reduced tem perature t close to zero, any lm has an in-plane correlation length k. Then, the total magnitude of $(k)^2 + l^2$ for dierent thickness lwill also be dierent. The thicker the lm, the correlation length the more dierent from 2d and the closer to 3d it will be. However, thick Ims are beyond the scope of this study and we nd that, for thin-lms with thickness around 8 layers and thinner, the exponents are very close to the 2d values. Thus, we feel that it is quite safe to conclude that thin- lms belong to the 2d class. In addition, our results show that, at a good level of agreem ent, the critical exponents from all structures represent the same universality class.

Finally, we compare our results for the exponent with those available from an experiment with Nilms [3]. As shown in Fig. 7, the experimental results are close to ours only for lms thinner than 4 layers. This is not surprising because the anisotropic Heisenberg magnet becomes Ising-like only for very thin-lms. However, instead of a sharp dimensional crossover of at around 5 to 8 layers [3], we found a trend which suggests that a dimensional crossover from 2d-to 3d-Ising should occur form uch thicker lms.

This is perhaps indicated by the slight increase of = towards its bulk value from 1=10 onwards. This issue may also be partly answered in that the dimensional crossover of = in [3] may really be a transition from 2d-Ising to 3d-Heisenberg instead of from 2d-to 3d-Ising in our study. So, a direct comparison may not be allowed. Nevertheless, although Ising and Heisenberg = Image may be quantitatively different, they should qualitatively share same characteristics since, in the critical region, the divergence of = in both models is 2d-like. So, it is strange that = in = in = should change its value so abruptly with very few layers. To = nd more answers, we consider = (Schilbe et al,1996) which claimed the author of = neglected the dependence of the (experimental data'. In other words, the range of temperatures = 10 = 10 = 10 = 11 used for the power law = tin = 13 may not belong to the asymptotic behaviour (critical region), and the = 12 may lead to somewhat dubious results. So, to investigate this closely, we follow = 12 who defined

$$e = \frac{\theta \log m}{\theta \log t}; \tag{10}$$

and study how this varies with tin thin- lms.

From M onte Carlo \sin ulations in \sin Ising thin- \sin for temperatures below but close to π , results of 10 sc lms are shown in Fig. 8. The qure shows how, close to T for each logm against logt for L L, the correlation length notices the nite size L, that is where the nite size e ect becomes important. Roughly, depending on the value of (see Table I), / t will realise its nite limit at a temperature around $\log t = \frac{1}{2} \log L$. We have also plotted e against $\log t$ for 100 100 1 lm s in Fig. 9. It is found that the pattern of the $_{\rm e}$ curves is in agreem ent with the rough investigations in [12]. Since L = 100 is used in our calculation, the e are reliable (with minimum nite size e ect) only down to logt' However, this range of $\log t$ does cover most of the range $3 < \log t < 1$ 1 used in the power law and shows a quite interesting phenomenon. It appears that this range of temperature is not in the critical region because e for each lm is not constant, but peaks at a certain temperature. Outside the critical region, the correlation length grows as we increase the temperature towards T_c . As long as than the Im thickness, the Im tries to behave as the 3d bulk system and grows somewhat towards the 0.3258 [21]. However, at some temperature becomes comparable with the lm thickness and is only allowed to expand in the in-plane direction, that is 2d behaviour. Thus, and the resulting decrease results in a peak. We can also notice that the thicker the lm, the closer the peak can grow towards the bulk value. Of course, if one tries to perform the power law tin this range of tem perature, a sudden change of e will be observed.

We may conclude that the range $3 < \log t < 1$ used for the power law tin [3] is outside the critical region and the power law t should not work well. On the other hand, it must be emphasised that our exponents are extracted at the critical temperature by means of nite size scaling. Our exponents are the real critical exponents. This explains why the behaviour of in [3] should not relate to our results.

IV. CONCLUSION

We have studied the magnetic behaviour of Ising thin- lm s in sc, bcc, and fcc structures using extensive M onte C arlo simulations. We have found the dimensional crossover of both the magnetisation m and the magnetic susceptibility lm 2d - to 3d - like with increasing <math>lm thickness. The layer-components of m and have also been presented. The surface layers are found to have the lowest magnitudes whilst the innermost layers have the highest, a trend which is derived from the free boundary at the surface. (This behaviour is also found in our mean- lm 2d to 3d values with increasing <math>lm thickness. Results for square monolayers agree well with the exact Ising lm 2d to 3d values with increasing <math>lm thickness. Results for square monolayers agree well with the exact Ising lm 2d to 3d values with increasing <math>lm thickness. Results for square monolayers agree well with the exact Ising lm 2d to 3d values with increasing <math>lm thickness. Results for square monolayers agree well with the exact Ising lm 2d to 3d values with increasing <math>lm thickness. Results for square monolayers agree well with the exact Ising lm 2d to 3d values with increasing <math>lm thickness. Results for square monolayers agree well with the exact Ising lm 2d to 3d values with increasing <math>lm thickness. Results for square monolayers agree well with the exact Ising lm 2d to 3d values with increasing <math>lm thickness, lm 3d values with increasing <math>lm 3d values with increasing <math>lm

very well with that calculated directly from 3d simulations. This tting expression could also be used on the mean-eld calculations.

We exam ine the critical regime of these systems in detail and extract critical exponents. For this purpose we develop a nite size scaling method for lms. It is based on one assumption that a single correlation length = (1) is su cient to describe the critical behaviour of Ising lms. The validity of this assumption is successfully veried. From our results we nd a very weak variation of the critical exponents with respect to 1, the lm thickness. For thin-lms (1 8) the exponents are essentially the same as 2d and from this it can be implied that thin-lms fall into the 2d class. For thicker lms, however, (1 10) a weak 1 dependence is noticeable because 1 is thick enough for the correlation length to distinguish the geometry of the lms from that of a simple 2d lattice. As an example we present gures of the scaling functions for 10-layered sc lms which are constructed by using both their own 10-layer critical exponents and also the well-known 2d exponents. For large enough L (layer extent) we nd good collapsing (L-independence) for the thickness-specience exponents which underscores the accuracy of our results. This collapse degenerates for L! 1 which con mms that our nite size scaling analysis is valid only for L 1. When we use the 2d critical exponents in the scaling functions a slightly poorer data collapse is found which points to the real disparity between thin-lms and 2d exponents.

In comparison with the experimental results described in [3] our results for the thinner Ims bear up well. A direct comparison, however, is not possible. This is because the experimental data from nickel Ims on a tungsten substrate can be interpreted to show a transition from 2d-Ising to 3d-Heisenberg rather than from 2d-Ising to 3d-Ising which is the only possibility for the model we have studied here. There is also the issue that the experimental data used to make a power law that are taken from temperatures that are outside the critical regime.

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APPENDIX A:FINITE SIZE SCALING

Consider the susceptibility

$$k_{B} T = \frac{1}{L_{x}L_{y}L_{z}} \frac{\dot{X}_{x} \dot{X}_{y} \dot{X}_{z} \dot{X}_{x} \dot{X}_{y} \dot{X}_{z}}{x_{1}=1} \frac{\dot{X}_{z} \dot{X}_{y} \dot{X}_{z}}{x_{1}=1} \frac{\dot{X}_{z} \dot{X}_{y} \dot{X}_{z}}{x_{2}=1} < m (x_{1}; y_{1}; z_{1}) m (x_{2}; y_{2}; z_{2}) > (A 1)$$

where we set the lattice spacing as 1. We use periodic boundary conditions along the x and y directions. Changing the index z_2 to z_1 + z under a condition that L_x and L_y 1, we can write

$$k_B T$$
 ' $\frac{1}{L_z} \begin{bmatrix} z_{L_x} & z_{L_y} & x_z & z_{L_x} \\ 0 & 0 & dy \\ z_{1}=1 & z=1 & z_1 \end{bmatrix} < m (0;0;z_1)m (x;y;z_1+z) > (A 2)$

Next, suppose that the two-point correlation function for an isotropically shaped system at T_{C} takes the form [34]

$$G_{c}^{(2)}(r;T_{c}) < m (0)m (r) > < m >^{2} \frac{1}{r^{d}^{2+}} (x^{2} + y^{2} + z^{2})^{-(d-2+-)=2}$$
 (A 3)

(where $r = jr_1 \quad r_2 j$ d is the dimension of the system, and is a critical exponent) and that this form is also valid for anisotropically shaped systems like lm s, we rewrite the susceptibility

where we have scaled the variables $x \,!\, L_x x^0$ and $y \,!\, L_y y^0$. In the thin- Imstructure, we set $L_x = L_y = L$ and $L_z = L_y$ so that

As z [1 1;1 1] and if we choose 1 $L_{\overline{L^2}}^{z^2}$ 1, this yields $\frac{P}{z_1} = \frac{P}{z_1} \frac{1}{z_1} \frac{z_1}{z_1} (x^2 + y^2 + \frac{z^2}{L^2})$ $\frac{2}{1}(x^2 + y^2)$. So the susceptibility becomes

$$k_B T_C$$
 (T_C) $1(L^2)^{1-\frac{d-2+}{2}} \sum_{0}^{Z-1} dx^0 dx^0 (x^0 + y^0)^{-(d-2+-)=2}$
/ $L^{=+2 d} 1$ / $L^{(==)^0}$; (A 6)

where the scaling relation ==2 (e.g. [29]) has been used. Note that for a particular thin— lm system, lis a constant so the only variable in the function is L. Consequently, in thin— lm s, if l L, scales with L in the same way as isotropic—shaped systems, but with a dierent exponent (= $^{\circ}$) =+2 d. For < m > T_C, we may assume that it is of the same order as the root mean square magnetisation < m 2 > T_C. So,

$$< m >_{T_C} / < m^2 >_{T_C}^{1=2} = \frac{k_B T_C (T_C)}{L^2 l}^{\#_{1=2}};$$
/ L = ; (A7)

where again we have used =(2) d=2= = [29]. Note that since = (1) in our hypothesis is a function of thickness l, every exponent calculated in this way will also be a function of thickness.

APPENDIX B:MEAN-FIELD APPROXIMATION

In a mean- eld study of thin- lm s, the average W eiss eld is layer-dependent. We write down the expression for the free energy for an 1-layered lm s and obtain the equations of state from its m in in isation with respect to the layer-resolved magnetisations m_k (k is a layer index). The 1-coupled equations are solved numerically to extract the equilibrium magnetisations m_k . The magnetisation per site in the k^{th} layer is given as $m_k = P_{k;r}$ $P_{k;\#}$ where $P_{k;(r;\#)}$ is the probability of a site being occupied by an up (down) spin. Including the interaction with an external eld ($h_i S_i$) the interaction energy U is the sum over all layers (k = 1; ;1) of term which are written as

$$E_{k} = \frac{N_{k}}{2} \sum_{0}^{n} Z_{0} J_{kk} m_{k}^{2} + Z_{1} J_{k;k+1} m_{k} m_{k+1} (1 \qquad k;l) + Z_{1} J_{k;k+1} m_{k} m_{k+1} (1 \qquad k;l) + 2hm_{k}^{0};$$
 (B1)

where Z_0 and Z_1 are the number of nearest neighbors to a lattice site in the same layer and one of its adjacent layers, and N_k is the number of sites in a layer. The free boundary condition necessitates the presence of the factors $1_{k;1}$ and $1_{k;1}$ in the equation. Similarly the entropy S can be written as $S = \begin{bmatrix} 1 \\ k=1 \end{bmatrix} S_k$ where

$$S_{k} = k_{B} N_{k} \left[P_{k;"} \ln P_{k;"} + (1 P_{k;"}) \ln (1 P_{k"})\right]$$

$$= k_{B} N_{k} \frac{1 + m_{k}}{2} \ln \frac{1 + m_{k}}{2} + \frac{1 m_{k}}{2} \ln \frac{1 m_{k}}{2} : \tag{B2}$$

Thus, by m in im ising the free energy F = U TS with respect to m_k i.e. $\frac{\ell F}{\ell m_k} = 0$, we obtain the equilibrium m agnetisation in layer k by solving the following 1-coupled equations for 1-layered Im s

$$(Z_{0}J_{1;1}m_{1} + Z_{1}J_{1;2}m_{2} + h) + \frac{k_{B}T}{2} \ln \frac{1+m_{1}}{1-m_{1}} = 0;$$

$$(Z_{0}J_{k;k}m_{k} + Z_{1}J_{k;k+1}m_{k+1} + Z_{1}J_{k;k+1}m_{k+1} + h) + \frac{k_{B}T}{2} \ln \frac{1+m_{k}}{1-m_{k}} = 0; \quad k = 2;$$

$$(Z_{0}J_{1;1}m_{n} + Z_{1}J_{1;1}m_{11} + h) + \frac{k_{B}T}{2} \ln \frac{1+m_{1}}{1-m_{1}} = 0; \quad (B3)$$

 T_{C} can also be extracted from eqn. (B3) for zero external eld. Close to T_{C} , the fm $_{i}g$ are small and $\ln\frac{1+m_{\,k}}{1\,m_{\,k}}$ $2m_{i}$ and T_{C} can be extracted by nding the temperature for which the set of equations A m = 0, where A is a 1 1m atrix with elements

$$A_{ij} = (k_B T \quad Z_0 J_{ij})_{ij} \quad Z_1 J_{ij} f (1 \quad _{ii})_{ij} \quad + (1 \quad _{ij})_{ij+1} g;$$
 (B4)

and m is a 1 1 column matrix, fm_1 ; g_* ; its satisfied.

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	# layers				T_{C}	=			= + 2 d			1=			
		М	С		ΜF										
	2D (Exact)	2.269185			4	0.125			1.75			1			
sc	1	2:2693	3	10 ⁴	4		0:126	1	10 ³	1 : 753	8	10 ³	1:01	2	10 ²
	2	3:2076	4	10^{4}	5		0:126	7	10^{3}	1 : 750	7	10^{3}	1:00	1	10 ²
	4	3 : 8701	3	10^{4}	5 . 61803		0:125	2	10^{3}	1 : 730	1	10^{2}	1:00	2	10^{2}
	6	4 : 1179	3	10^{4}	5.80194		0:131	2	10^{3}	1 : 740	1	10^{2}	1:02	2	10 ²
	8	4:2409	2	10^{4}	5 . 87939		0:141	2	10 ³	1 : 744	7	10 ³	1:03	1	10 ²
	10	4:3117	3	10^{4}	5 . 91899		0:144	2	10 ³	1 : 720	1	10^{2}	1:00	3	10 ²
	15	4:3996	4	10^{4}	5 . 96157		0:162	2	10 ³	1 : 680	1	10^{2}	1:02	1	10 ²
	20	4 : 4381	2	10^{4}	5 . 97766		0:166	3	10^{3}	1 : 660	2	10^{2}	1:03	1	10 ²
	Bulk	4 : 5115	2	10^{4}	6		0:507	4	10^{3}	0 : 980	1	10^{2}	1:57	3	10 ²
	Buk	4:5390	6	10 ³	6 : 00200 2	10^{4}		_			-			_	
bcc	2	2:2691	1	10 ⁴	4		0:120	5	10 ³	1:760	3	10 ²	1:01	1	10 ²
	4	4:2947	3	10^{4}	6.47214		0:124	5	10 ³	1 : 760	4	10^{2}	1:00	1	10 ²
	6	5 : 1023	4	10^{4}	7.20775		0:130	6	10 ³	1 : 762	6	10 ³	1:02	1	10 ²
	8	5 : 5005	3	10^{4}	7.51754		0:131	1	10^{3}	1 : 752	7	10^{3}	1:02	1	10^{2}
	10	5 : 7287	2	10^{4}	7 . 67594		0:136	1	10^{3}	1 : 748	7	10^{3}	1:04	1	10^{2}
	15	6 : 0076	4	10^{4}	7.84628		0:153	2	10 ³	1 : 730	1	10^{2}	1:06	1	10 ²
	20	6:1300	3	10^{4}	7 . 91065		0:169	3	10^{3}	1 : 700	1	10^{2}	1:06	1	10^{2}
	Bulk	6 : 3557	1	10^{4}	8		0:505	3	10 ³	1:001	4	10 ³	1 : 60	1	10 ²
	Bulk	6:3890	3	10 ³	8:03200 4	10 ³		_			_			_	
	1	2:2690	2	10^{4}	4		0:124	3	10 ³	1:740	2	10 ²	1:00	2	10 ²
fcc	2	5:2416	6	10^{4}	8		0:126	3	10^{3}	1 : 751	6	10^{3}	0:99	1	10 ²
	4	7:5702	3	10^{4}	10.47210		0:126	1	10^{3}	1 : 750	1	10^{2}	0:99	3	10 ²
	6	8 : 4431	3	10^{4}	11.20780		0:128	1	10^{3}	1 : 751	4	10 ³	1:01	1	10 ²
	8	8 : 8679	7	10^{4}	11.51750		0:130	2	10 ³	1 : 740	1	10^{2}	1:00	1	10 ²
	10	9:1106	6	10^{4}	11.67590		0:138	3	10 ³	1 : 730	1	10^{2}	1:00	2	10 ²
	15	9 : 4057	3	10^{4}	11.84630		0:153	2	10^{3}	1 : 720	1	10^{2}	1:03	2	10^{2}
	20	9 : 5353	5	10^{4}	11.91060		0:173	3	10^{3}	1 : 710	1	10^{2}	1 : 07	2	10 ²
	Buk	9 : 7736	2	10^{4}	12		0 : 498	8	10^{3}	0 : 994	9	10^{3}	1:59	3	10^{2}
	Bulk	9:8600	2	10^{2}	12:04500 6	10 ³		-			_			_	

TABLE I: The critical tem peratures determ ined by both M onte C arlo (M C) simulations and also mean-eld (M F) calculations for Ising lms. Bulk 3d results are also given for comparison. Bulk refers to the T_C (1) parameter of the thing expression of eqn. (8). C ritical exponents are given which have been extracted from the M C simulations via a nite size scaling analysis. Since we can extract the ratio of exponents = for the bulk 3d system we give (= \hat{Y} as = +2 3

	Structure	T _C (1)			<u>l</u> 0			10			0			(1) = 1 = 3d		
МС	sc	4 : 539	6	10 ³	1:010	2	10^{2}	0:010	2	16	1:280	2	10 ²	1:578	3	10 ³
	bcc	6 : 389	3	10^{3}	1 : 933	7	10^{3}	0 : 746	7	10^{3}	1:380	6	10^{3}	1 : 620	1	10^{2}
	fcc	9 : 860	2	10^{2}	1 : 416	6	10 ³	0:440	7	10^{3}	1:300	1	10^{2}	1 : 621	8	10 ³
ΜF	sc	6 : 0020	2	10^{4}	1:117	3	10 ³	0 : 61	4	16	1 : 894	3	10 ³	2:002	4	10 ³
	bcc	8 : 0320	4	10^{3}	1:380	1	10 ³	0 : 63	2	10^{2}	1 : 600	6	10^{2}	2 : 002	2	10 ³
	fcc	12:0500	6	10 ³	1:120	1	10 ²	0:28	1	10 ²	1:580	1	10 ²	2 : 000	2	10 ³

TABLE II: Fitting parameters for Ising thin-lms using eqn. (8). MC and MF stand for Monte Carlo and mean-eld respectively.

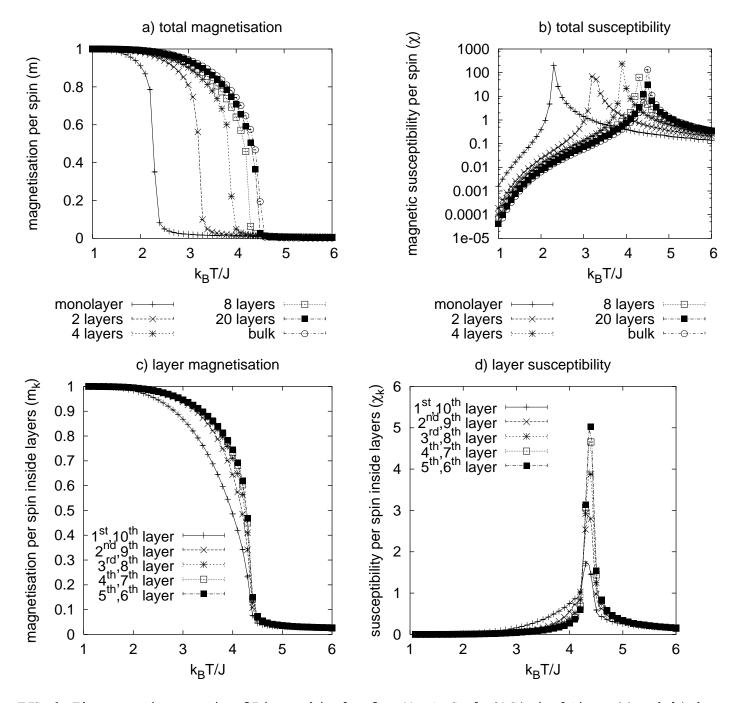


FIG. 1: The magnetic properties of Ising sc thin- Im s from M onte Carlo (MC) simulations. (a) and (b) show a dimensional crossover of m and respectively from 2d- to bulk-like for 128 128 1 spins (1 is the number of layers in the Im and l=128 represents the bulk system). (c) and (d) show the layer-dependence of m $_k$ and $_k$, where k is a layer index, in 128 128 10 sc Im s. O wing to the isotropic exchange interaction and spatial symmetry, layers k and 10 k have the same properties. Lines are added as a viewing aid. The error bars are smaller than point size.

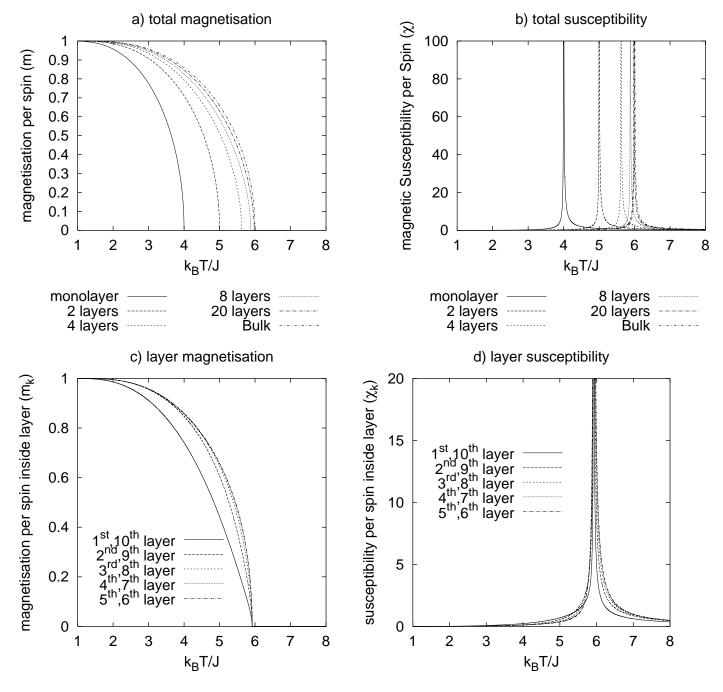


FIG. 2: The magnetic properties of Ising sc thin-lms from mean-eld calculations. As in Fig. 1, (a) and (b) show a crossover of m and from the 2d to the bulk limit ($k_B T_C = J$ varies from 4 to 6). (c) and (d) show examples of the layer dependence of m $_k$ and $_k$ for 10-layered sc lms.

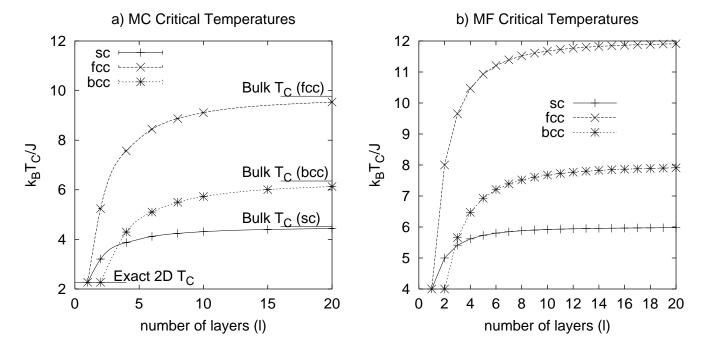


FIG. 3: The critical tem peratures T_C as a function of thickness lextracted from (a) M onte Carlo simulations and (b) mean-eld calculations. For mean-eld, the values of $k_B T_C = J$ are 4 for 2d and 6, 8 and 12 for bulk sc, bcc, and for respectively. Lines are added as a viewing aid. The error bars in (a) are smaller than point size.

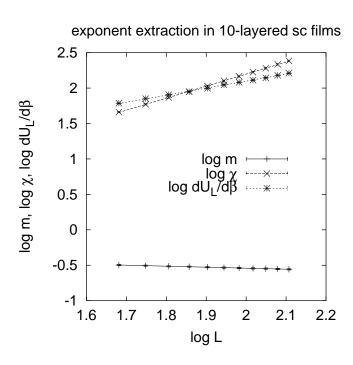


FIG. 4: An example of the extraction of critical exponents (=), and 1= from the slope of a least-square—t (see text) for 10-layered sc lms. The apparent linear relation supports eqn. (3)

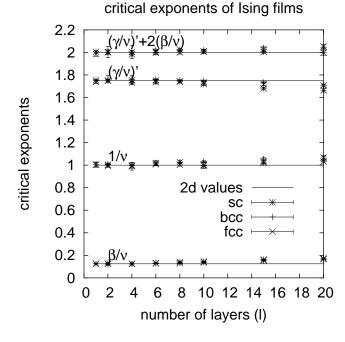


FIG. 5: Results of critical exponents for all sc, bcc, and fcc lm s. In all structures the exponents are very close to 2d values. Especially, for thin-lm s (1 8 approximately), the exponents are consistent with 2d results and suggest that thin-lm s belong to the 2d class. The sum mation $(=)^0+2=)=2$ supports our single correlation length assumption.

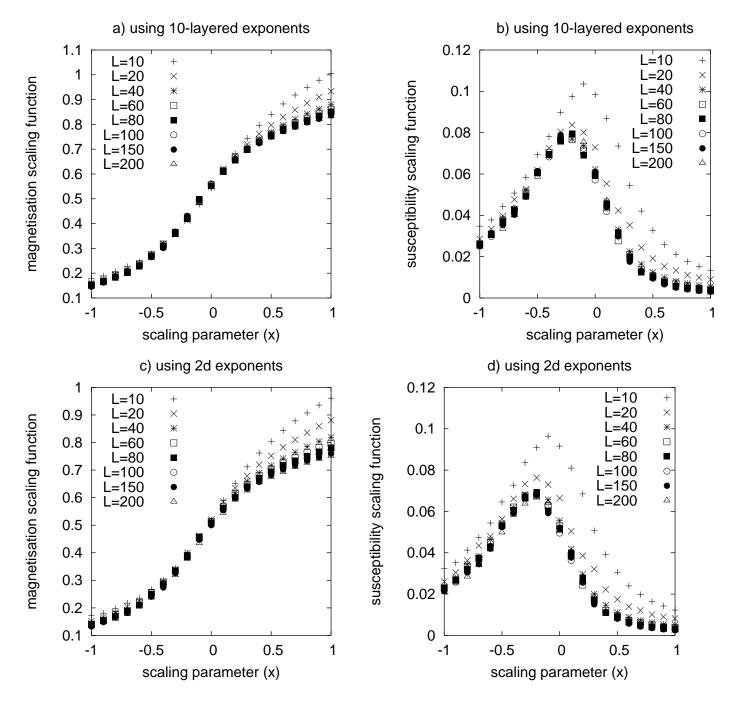
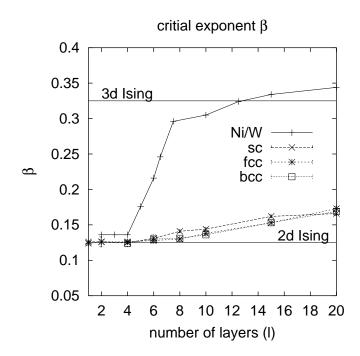
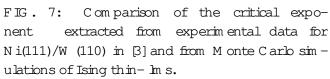


FIG. 6: The scaling functions for the magnetisation (a) and susceptibility (b) in 10 layered sc systems with L from 100 to 200 calculated by using those critical exponents extracted for 10-layered sc $\ln s$ with L ranging from 64 to 128. A nalogous plots using 2d critical exponents are shown in (c) and (d). In (a) and (b), we indicated a good collapse of the data for all systems with L in 60 including L = 150;200 which are bigger than those used in the exponent extraction. Note, however, that for L close to the thickness l = 10, the collapsing is not found since the assumption underpinning our inite size scaling relation (eqn. 3) rests on the condition L. L. In (c) and (d) we indicated a slightly worse collapsing than that in (a) and (b) - compare, for example, the collapsing around x = 1 in (c) and (a). This con is the weak 1 dependence of critical exponents and the deviation from the 2d values when the $\ln s$ thicken.





double logarithmic plot of m against t 0.00 L = 10L = 20X -0.05L = 40* L = 60 $\overline{}$ -0.10L = 80L = 100-0.15log m -0.20-0.25-0.30-0.35-0.40 -3 -2.5 -2 -1.5 -1 -0.5 0 -3.5 log t

FIG. 8: Double logarithm ic plot of magainst t, the reduced temperature, for 4-layered Ising so lms. The nite size e ect is evident once becomes comparable to the size L of the layers of the lms. Note the data is reliable down to log t $\frac{1}{2} \log L$

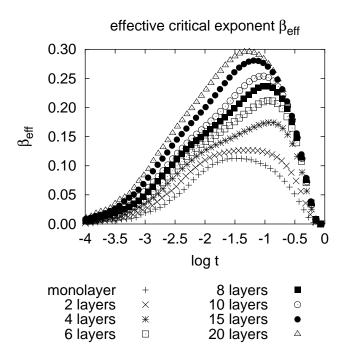


FIG. 9: The electric critical exponent $_{\rm e}$ extracted from 100 $_{\rm e}$ 100 $_$